# International Rectifier

- Generation V Technology
- Ultra Low On-Resistance
- Dual P-Channel MOSFET
- Surface Mount
- Very Low Gate Charge and Switching Losses
- Fully Avalanche Rated
- Lead-Free

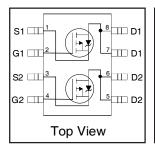
#### Description

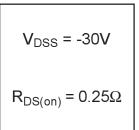
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques.

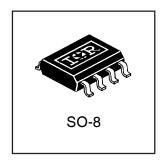
## IRF9953PbF

**HEXFET® Power MOSFET** 





Recommended upgrade: IRF7306 or IRF7316 Lower profile/smaller equivalent: IRF7506



### Absolute Maximum Ratings (T<sub>A</sub> = 25°C Unless Otherwise Noted)

|  |                       | Symbol                           | Maximum      | Units |  |
|--|-----------------------|----------------------------------|--------------|-------|--|
| Drain-Source Voltage                         |                       | V <sub>DS</sub>                  | -30          | v     |  |
| Gate-Source Voltage                          |                       | V <sub>GS</sub>                  | ± 20         |       |  |
| Continuous Drain Current®                    | T <sub>A</sub> = 25°C |                                  | -2.3         |       |  |
| Continuous Diam Current                      | T <sub>A</sub> = 70°C | l <sub>D</sub>                   | -1.8         | - A   |  |
| Pulsed Drain Current                         |                       | I <sub>DM</sub>                  | -10          |       |  |
| Continuous Source Current (Diode Conduction) |                       | Is                               | 1.6          |       |  |
| Maximum Power Dissipation ⑤                  | T <sub>A</sub> = 25°C | - P <sub>D</sub>                 | 2.0          | - W   |  |
|  | $T_A = 70$ °C         | ГБ                               | 1.3          |       |  |
| Single Pulse Avalanche Energy                |                       | E <sub>AS</sub>                  | 57           | mJ    |  |
| Avalanche Current                            |                       | I <sub>AR</sub>                  | -1.3         | Α     |  |
| Repetitive Avalanche Energy                  |                       | E <sub>AR</sub>                  | 0.20         | mJ    |  |
| Peak Diode Recovery dv/dt③                   |                       | dv/dt                            | -5.0         | V/ ns |  |
| Junction and Storage Temperature Range       |                       | T <sub>J,</sub> T <sub>STG</sub> | -55 to + 150 | °C    |  |

#### **Thermal Resistance Ratings**

| Parameter                    | Symbol           | Limit | Units |
|------------------------------|------------------|-------|-------|
| Maximum Junction-to-Ambient® | R <sub>θJA</sub> | 62.5  | °C/W  |

7/16/04

### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

|                                 | Parameter                            | Min. | Тур.  | Max.  | Units | Conditions   |
|---------------------------------|--------------------------------------|------|-------|-------|-------|--|
| V <sub>(BR)DSS</sub>            | Drain-to-Source Breakdown Voltage    | -30  |       |       | V     | $V_{GS} = 0V, I_D = -250\mu A$                                     |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  |      | 0.015 |       | V/°C  | Reference to 25°C, I <sub>D</sub> = -1mA                           |
| R <sub>DS(on)</sub>             | Static Drain-to-Source On-Resistance |      | 0.165 | 0.250 | 0     | V <sub>GS</sub> = 10V, I <sub>D</sub> = -1.0A ⊕                    |
|                                 |                                      |      | 0.290 | 0.400 |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = -0.50A ④                  |
| V <sub>GS(th)</sub>             | Gate Threshold Voltage               | -1.0 |       |       | V     | $V_{DS} = V_{GS}$ , $I_D = -250\mu A$                              |
| 9fs                             | Forward Transconductance             |      | -2.4  |       | S     | $V_{DS} = -15V, I_{D} = -2.3A$                                     |
| I <sub>DSS</sub>                | Drain-to-Source Leakage Current      |      |       | -2.0  |       | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V                        |
|                                 | Dialii-to-Source Leakage Current     |      |       | -25   | μA    | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C |
| lana                            | Gate-to-Source Forward Leakage       |      |       | 100   | nA    | V <sub>GS</sub> = -20V   |
| I <sub>GSS</sub>                | Gate-to-Source Reverse Leakage       |      |       | -100  | IIA   | $V_{GS} = 20V$   |
| Qg                              | Total Gate Charge                    |      | 6.1   | 12    |       | I <sub>D</sub> = -2.3A   |
| Q <sub>gs</sub>                 | Gate-to-Source Charge                |      | 1.7   | 3.4   | nC    | $V_{DS} = -10V$  |
| Q <sub>gd</sub>                 | Gate-to-Drain ("Miller") Charge      |      | 1.1   | 2.2   |       | V <sub>GS</sub> = -10V, See Fig. 10 ④                              |
| t <sub>d(on)</sub>              | Turn-On Delay Time                   |      | 9.7   | 19    |       | $V_{DD} = -10V$  |
| t <sub>r</sub>                  | Rise Time                            |      | 14    | 28    | ns    | $I_D = -1.0A$  |
| t <sub>d(off)</sub>             | Turn-Off Delay Time                  |      | 20    | 40    | 115   | $R_G = 6.0\Omega$  |
| t <sub>f</sub>                  | Fall Time                            |      | 6.9   | 14    |       | $R_D = 10\Omega \ \oplus$  |
| C <sub>iss</sub>                | Input Capacitance                    |      | 190   |       |       | V <sub>GS</sub> = 0V   |
| Coss                            | Output Capacitance                   |      | 120   |       | pF    | $V_{DS} = -15V$  |
| C <sub>rss</sub>                | Reverse Transfer Capacitance         |      | 61    |       |       | f = 1.0MHz, See Fig. 5   |

### Source-Drain Ratings and Characteristics

|                 | Parameter                 | Min. | Тур. | Max. | Units               | Conditions   |
|-----------------|---------------------------|------|------|------|---------------------|--|
| Is              | Continuous Source Current |      |      | 4.0  |                     | MOSFET symbol  |
|                 | (Body Diode)              |      |      | 1.3  |                     | showing the  |
| I <sub>SM</sub> | Pulsed Source Current     |      |      | 40   | A                   | integral reverse G                                     |
|                 | (Body Diode) ①            |      | 16   |      | p-n junction diode. |  |
| V <sub>SD</sub> | Diode Forward Voltage     |      | 0.82 | 1.2  | V                   | $T_J = 25^{\circ}C$ , $I_S = -1.25A$ , $V_{GS} = 0V$ ③ |
| t <sub>rr</sub> | Reverse Recovery Time     |      | 27   | 54   | ns                  | T <sub>J</sub> = 25°C, I <sub>F</sub> = -1.25A         |
| Q <sub>rr</sub> | Reverse RecoveryCharge    |      | 31   | 62   | nC                  | di/dt = -100A/µs ③                                     |

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J$  = 25°C, L = 67mH  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = -1.3A.
- $\label{eq:loss_def} \begin{tabular}{ll} $ I_{SD} \le -1.3A, \ di/dt \le -92A/\mu s, \ V_{DD} \le V_{(BR)DSS}, \\ $ T_J \le 150^{\circ}C $ \end{tabular}$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .

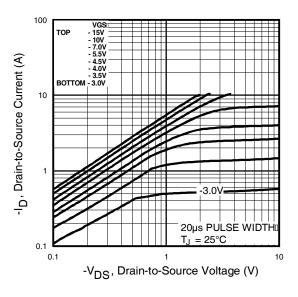


Fig 1. Typical Output Characteristics

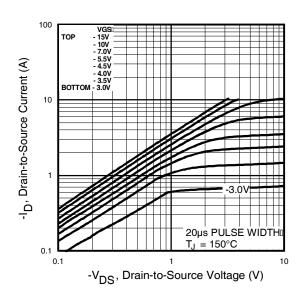


Fig 2. Typical Output Characteristics

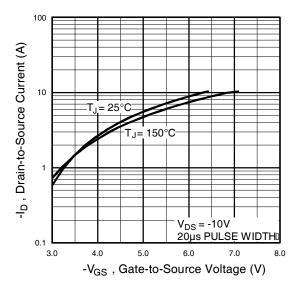


Fig 3. Typical Transfer Characteristics

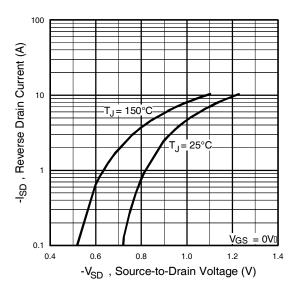
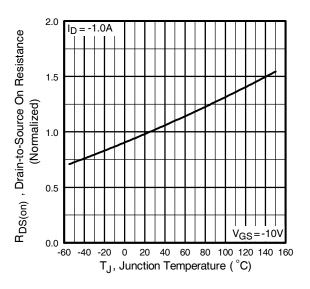
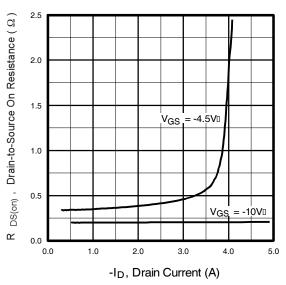


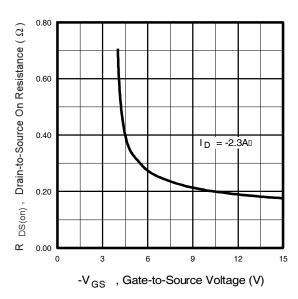
Fig 4. Typical Source-Drain Diode Forward Voltage



**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current



**Fig 7.** Typical On-Resistance Vs. Gate Voltage

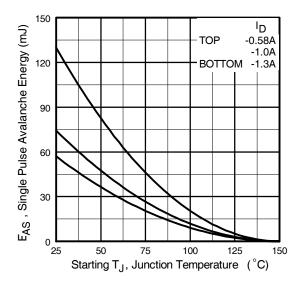
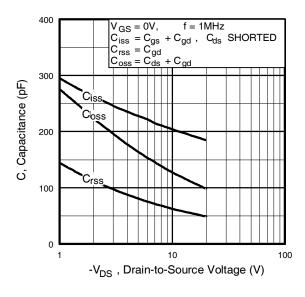


Fig 8. Maximum Avalanche Energy Vs. Drain Current



**Fig 9.** Typical Capacitance Vs. Drain-to-Source Voltage

**Fig 10.** Typical Gate Charge Vs. Gate-to-Source Voltage

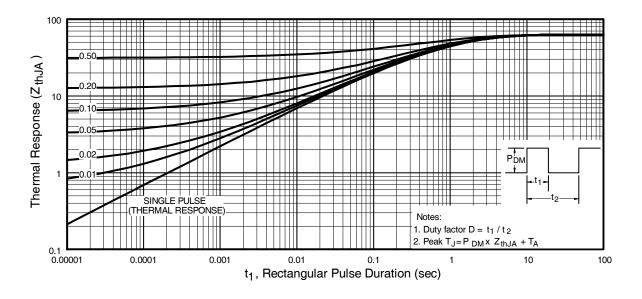
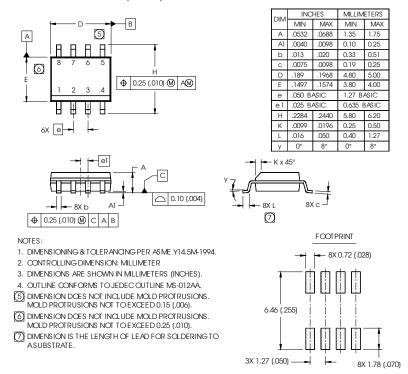


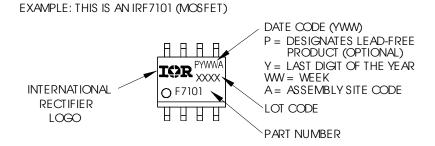
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

### SO-8 Package Outline

Dimensions are shown in milimeters (inches)

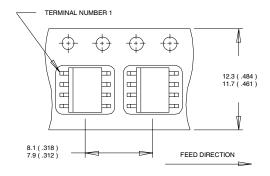


### SO-8 Part Marking Information (Lead-Free)



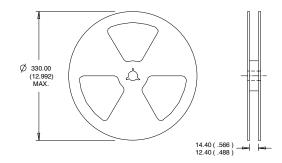
### SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



#### NOTES:

- CONTROLLING DIMENSION: MILLIMETER.
  ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
  OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES:
  1. CONTROLLING DIMENSION: MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

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